

Search Notes

Application/Control No.

10/735,783

Examiner

Winnie Yip

Applicant(s)/Patent under
Reexamination

CHEN, HSIA-HUI

Art Unit

3637

SEARCHED

Class	Subclass	Date	Examiner
135	25.1 25.3 25.31	9/23/2005	WSY
	25.32 31	↓	↓
	32		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text Searched in EAST	9/23/2005	WSY